Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,673	CHA ET AL.	
Examiner	Art Unit	
Sara W. Crane	2811	_

SEARCHED					
Class	Subclass	Date	Examiner		
315	1693	9/06	SwC		
725	74-77				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		, , ,			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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